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APPLICATION NO.	FI	LING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO. /	
10/667,786	0	9/23/2003	Martin Dieterle	243117US0 9557		
22850	7590	02/24/2006		EXAMINER		
OBLON, SI		MCCLELLAND, N	PUTTLITZ, KARL J			
ALEXANDRIA, VA 22314				ART UNIT	PAPER NUMBER	
	•			1621		

DATE MAILED: 02/24/2006

Please find below and/or attached an Office communication concerning this application or proceeding.

Supplemental	Application No.	Applicant(s)	
•	10/667,786	DIETERLE ET AL.	
Notice of Allowability	Examiner	Art Unit	
	Karl J. Puttlitz	1621	
The MAILING DATE of this communication app All claims being allowable, PROSECUTION ON THE MERITS IS herewith (or previously mailed), a Notice of Allowance (PTOL-85 NOTICE OF ALLOWABILITY IS NOT A GRANT OF PATENT R of the Office or upon petition by the applicant. See 37 CFR 1.313	(OR REMAINS) CLOSED in this a ) or other appropriate communicati RIGHTS. This application is subjec	application. If not include on will be mailed in due	ed course. <b>THIS</b>
1. $igspace$ This communication is responsive to <u>Reply filed 6/27/2005</u>	<u>5</u> .		
2. 🔀 The allowed claim(s) is/are <u>1-27</u> .			
a)  Acknowledgment is made of a claim for foreign priority u a)  All b)  Some* c)  None of the:  1.  Certified copies of the priority documents have 2.  Certified copies of the priority documents have 3.  Copies of the certified copies of the priority documents have 1.  Certified copies of the priority documents have 3.  Copies of the certified copies of the priority documents have 1.  Acquired to time to the certified copies of the priority documents have 2.  Certified copies of the priority documents have 3.  Copies of the priority documents have 3.  Copies of the priority documents have 4.  Certified copies not received:  Applicant has THREE MONTHS FROM THE "MAILING DATE" noted below. Failure to timely comply will result in ABANDONN THIS THREE-MONTH PERIOD IS NOT EXTENDABLE.  4.  A SUBSTITUTE OATH OR DECLARATION must be submined in INFORMAL PATENT APPLICATION (PTO-152) which give submined in the complex of the priority documents have a priority in the least of the priority documents have a priority document have a paper No./Mail Date  [b)  including changes required by the Notice of Draftsper	e been received. e been received in Application No. comments have been received in the formal of this communication to file a report of this application.  Initted. Note the attached EXAMINE (see reason(s)) why the oath or declarst be submitted. son's Patent Drawing Review (PT)  's Amendment / Comment or in the transfer of BIOLOGICAL MATERIAL Disit of BIOLOGICAL MATERIAL	is national stage applicated by complying with the recent of the recent of the complying with the recent of the complex of the	quirements OTICE OF
Attachment(s)  1.  Notice of References Cited (PTO-892)  2.  Notice of Draftperson's Patent Drawing Review (PTO-948)  3.  Information Disclosure Statements (PTO-1449 or PTO/SB/Paper No./Mail Date  4.  Examiner's Comment Regarding Requirement for Deposit of Biological Material	6. Interview Summa Paper No./Mail [ 08), 7. Examiner's Amer  8. Examiner's State  9. Other  HIEH	Date	·

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## SUPPLEMENTAL EXAMINER'S AMENDMENT

An examiner's amendment to the record appears below. Should the changes and/or additions be unacceptable to applicant, an amendment may be filed as provided by 37 CFR 1.312. To ensure consideration of such an amendment, it MUST be submitted no later than the payment of the issue fee.

Authorization for this examiner's amendment was given in a telephone interview with Don Drummond on 1/17/2006.

Enter the following at page 3, line 25 of the Specification:

## BRIEF DESCRIPTION OF THE DRAWINGS

- Fig. 1- Schematic of the rotating bulb furnace
- Fig, 2 X-ray diffraction pattern of Comparative Example 1
- Fig. 3 X-ray diffraction pattern of Example 1
- Fig. 4 X-ray diffraction pattern of Comparative Example 2
- Fig. 5 X-ray diffraction pattern of Example 2
- Fig. 6 X-ray diffraction pattern of Comparative Example 3
- Fig. 7 X-ray diffraction pattern of Example 3
- Fig. 8 X-ray diffraction pattern of Comparative Example 4
- Fig. 9 X-ray diffraction pattern of Example 4
- Fig, I\_ 0 X-ray diffraction pattern of Comparative Example 5
- Fig. 11 -X-ray diffraction pattern of Example 5
- Fig. 12 X-ray diffraction pattern of Comparative Example 6

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Fig. 13 - ](-ray diffraction pattern of Example 6

Fig. 14 - X-ray diffraction pattern of Comparative Example 7

Fig. 15 - X-ray diffraction pattern of Example 7

Fig. 16 - X-ray diffraction pattern of Comparative Example 8

Fig, 17 - X-ray diffraction pattern of Comparative Example 9

## Conclusion

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Karl J. Puttlitz whose telephone number is (571) 272-0645. The examiner can normally be reached on Monday to Friday from 9 a.m. to 5 p.m.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Johann Richter, can be reached at telephone number (571) 272-0646. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

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Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

Karl J. Puttlitz
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Biotechnology and Organic Chemistry

Art Unit 1621 (571) 272-0646